

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



# Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China







### **Features**

- EE Programmable 65,536 x 1-, 131,072 x 1-, 262,144 x 1-, 524,288 x 1-, 1,048,576 x 1-, 2,097,152 x 1-, and 4,194,304 x 1-bit Serial Memories Designed to Store Configuration Programs for Field Programmable Gate Arrays (FPGAs)
- Supports both 3.3V and 5.0V Operating Voltage Applications
- In-System Programmable (ISP) via Two-Wire Bus
- Simple Interface to SRAM FPGAs
- Compatible with Atmel AT6000, AT40K and AT94K Devices, Altera<sup>®</sup> FLEX<sup>®</sup>, APEX<sup>™</sup> Devices, ORCA<sup>®</sup>, Xilinx<sup>®</sup> XC3000, XC4000, XC5200, Spartan<sup>®</sup>, Virtex<sup>™</sup> FPGAs
- Cascadable Read-back to Support Additional Configurations or Higher-density Arrays
- Very Low-power CMOS EEPROM Process
- Programmable Reset Polarity
- Available in 6 mm x 6 mm x 1 mm 8-lead LAP (Pin-compatible with 8-lead SOIC/VOIC Packages), 8-lead PDIP, 8-lead SOIC, 20-lead PLCC, 20-lead SOIC, 44-lead PLCC and 44-lead TQFP Packages
- Emulation of Atmel's AT24CXXX Serial EEPROMs
- Low-power Standby Mode
- · High-reliability
  - Endurance: 100,000 Write Cycles
  - Data Retention: 90 Years for Industrial Parts (at 85°C) and 190 Years for Commercial Parts (at 70°C)
- Green (Pb/Halide-free/RoHS Compliant) Package Options Available

### 1. Description

The AT17LV series FPGA Configuration EEPROMs (Configurators) provide an easy-to-use, cost-effective configuration memory for Field Programmable Gate Arrays. The AT17LV series device is packaged in the 8-lead LAP, 8-lead PDIP, 8-lead SOIC, 20-lead PLCC, 20-lead SOIC, 44-lead PLCC and 44-lead TQFP, see Table 1-1. The AT17LV series Configurators uses a simple serial-access procedure to configure one or more FPGA devices. The user can select the polarity of the reset function by programming four EEPROM bytes. These devices also support a write-protection mechanism within its programming mode.

The AT17LV series configurators can be programmed with industry-standard programmers, Atmel's ATDH2200E Programming Kit or Atmel's ATDH2225 ISP Cable.



# FPGA Configuration EEPROM Memory

AT17LV65 AT17LV128 AT17LV256 AT17LV512 AT17LV010 AT17LV002 AT17LV040

3.3V and 5V System Support





Table 1-1. AT17LV Series Packages

Package	AT17LV65/ AT17LV128/ AT17LV256	AT17LV512/ AT17LV010	AT17LV002	AT17LV040
8-lead LAP	Yes	Yes	Yes	(3)
8-lead PDIP	Yes	Yes	_	_
8-lead SOIC	Yes	Use 8-lead LAP <sup>(1)</sup>	Use 8-lead LAP <sup>(1)</sup>	(3)
20-lead PLCC	Yes	Yes	Yes	_
20-lead SOIC	Yes <sup>(2)</sup>	Yes <sup>(2)</sup>	Yes <sup>(2)</sup>	_
44-lead PLCC	_	_	Yes	Yes
44-lead TQFP	_	_	Yes	Yes

Notes:

- 1. The 8-lead LAP package has the same footprint as the 8-lead SOIC. Since an 8-lead SOIC package is not available for the AT17LV512/010/002 devices, it is possible to use an 8-lead LAP package instead.
- The pinout for the AT17LV65/128/256 devices is not pin-for-pin compatible with the AT17LV512/010/002 devices.
- 3. Refer to the AT17Fxxx datasheet, available on the Atmel web site.

# 2. Pin Configuration

2

Figure 2-1. 8-lead LAP

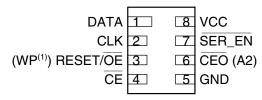


Figure 2-2. 8-lead SOIC

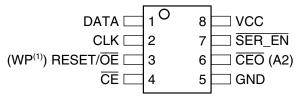


Figure 2-3. 8-lead PDIP

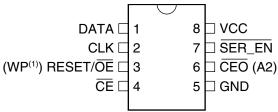
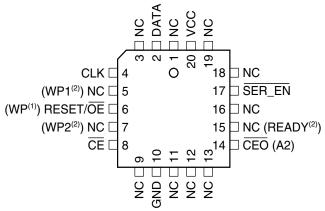


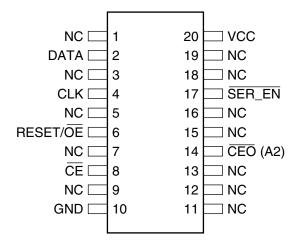
Figure 2-4. 20-lead PLCC



Notes: 1. This pin is only available on AT17LV65/128/256 devices.

- 2. This pin is only available on AT17LV512/010/002 devices.
- 3. The CEO feature is not available on the AT17LV65 device.

Figure 2-5. 20-lead SOIC<sup>(1)</sup>

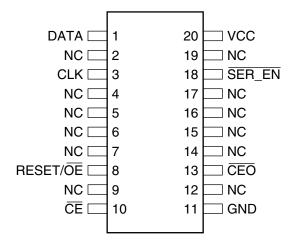


Note: 1. This pinout only applies to AT17LV65/128/256 devices.





Figure 2-6. 20-lead SOIC<sup>(1)</sup>



Notes: 1. This pinout only applies to AT17LV512/010/002 devices.

2. The CEO feature is not available on the AT17LV65 device.

Figure 2-7. 44 PLCC

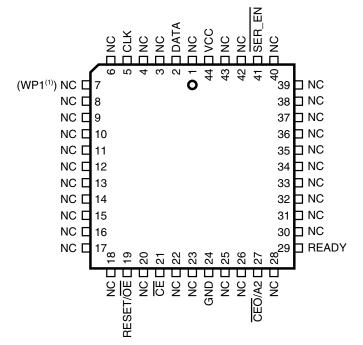
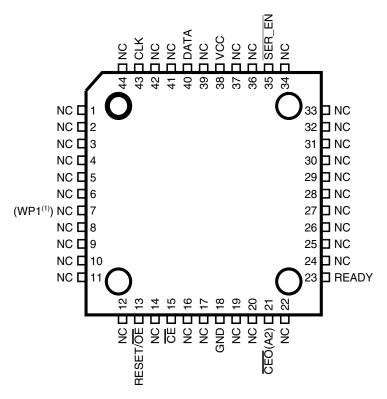


Figure 2-8. 44 TQFP

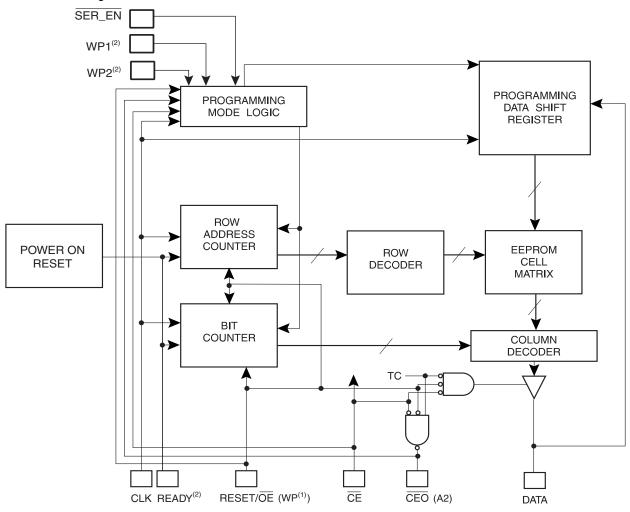


Note: 1. This pin is only available on AT17LV002 devices.





Figure 2-9. Block Diagram



Notes: 1. This pin is only available on AT17LV65/128/256 devices.

- 2. This pin is only available on AT17LV512/010/002 devices.
- 3. The CEO feature is not available on the AT17LV65 device.

### 3. Device Description

The control signals for the configuration EEPROM ( $\overline{\text{CE}}$ , RESET/ $\overline{\text{OE}}$  and CCLK) interface directly with the FPGA device control signals. All FPGA devices can control the entire configuration process and retrieve data from the configuration EEPROM without requiring an external intelligent controller.

The configuration EEPROM RESET/ $\overline{OE}$  and  $\overline{CE}$  pins control the tri-state buffer on the DATA output pin and enable the address counter. When RESET/ $\overline{OE}$  is driven High, the configuration EEPROM resets its address counter and tri-states its DATA pin. The  $\overline{CE}$  pin also controls the output of the AT17LV series configurator. If  $\overline{CE}$  is held High after the RESET/ $\overline{OE}$  reset pulse, the counter is disabled and the DATA output pin is tri-stated. When  $\overline{OE}$  is subsequently driven Low, the counter and the DATA output pin are enabled. When RESET/ $\overline{OE}$  is driven High again, the address counter is reset and the DATA output pin is tri-stated, regardless of the state of  $\overline{CE}$ .

When the configurator has driven out all of its data and  $\overline{\text{CEO}}$  is driven Low, the device tri-states the DATA pin to avoid contention with other configurators. Upon power-up, the address counter is automatically reset.

This is the default setting for the device. Since almost all FPGAs use RESET Low and OE High, this document will describe RESET/OE.

### 4. Pin Description

		A	AT17LV65 AT17LV128 AT17LV250	3/		AT17LV512 AT17LV01	-		,	AT17LV00	2		AT17	LV040
Name	I/O	8 DIP/ LAP/ SOIC	20 PLCC	20 SOIC	8 DIP/ LAP	20 PLCC	20 SOIC	8 DIP/ LAP/ SOIC	20 PLCC	20 SOIC	44 PLCC	44 TQFP	44 PLCC	44 TQFP
DATA	I/O	1	2	2	1	2	1	1	2	1	2	40	2	40
CLK	I	2	4	4	2	4	3	2	4	3	5	43	5	43
WP1	I	_	_	_	-	5	-	_	5	-	_	-	_	_
RESET/O E	I	3	6	6	3	6	8	3	6	8	19	13	19	13
WP2	I				-	7	-	-	7	-	-	-	_	_
CE	I	4	8	8	4	8	10	4	8	10	21	15	21	15
GND		5	10	10	5	10	11	5	10	11	24	18	24	18
CEO	0						13			13	07	0.4	07	0.4
A2	I	6	14	14	6	14	-	6	14	_	27	21	27	21
READY	0	-	_	I	-	15	-	-	15	-	29	23	29	23
SER_EN	I	7	17	17	7	17	18	7	17	18	41	35	41	35
V <sub>CC</sub>		8	20	20	8	20	20	8	20	20	44	38	44	38

Note: 1. The CEO feature is not available on the AT17LV65 device.





### 4.1 **DATA**

Three-state DATA output for configuration. Open-collector bi-directional pin for programming.

### 4.2 CLK

Clock input. Used to increment the internal address and bit counter for reading and programming.

### 4.3 WP1

WRITE PROTECT (1). Used to protect portions of memory during programming. Disabled by default due to internal pull-down resistor. This input pin is not used during FPGA loading operations. This pin is only available on AT17LV512/010/002 devices.

### 4.4 RESET/OE

Output Enable (active High) and RESET (active Low) when SER\_EN is High. A Low level on RESET/OE resets both the address and bit counters. A High level (with CE Low) enables the data output driver. The logic polarity of this input is programmable as either RESET/OE or RESET/OE. For most applications, RESET should be programmed active Low. This document describes the pin as RESET/OE.

### 4.5 WP

Write protect (WP) input (when  $\overline{CE}$  is Low) during programming only ( $\overline{SER}_{EN}$  Low). When WP is Low, the entire memory can be written. When WP is enabled (High), the lowest block of the memory cannot be written. This pin is only available on AT17LV65/128/256 devices.

### 4.6 WP2

WRITE PROTECT (2). Used to protect portions of memory during programming. Disabled by default due to internal pull-down resistor. This input pin is not used during FPGA loading operations. This pin is only available on AT17LV512/010 devices.

### 4.7 CE

Chip Enable input (active Low). A Low level (with OE High) allows CLK to increment the address counter and enables the data output driver. A High level on  $\overline{\text{CE}}$  disables both the address and bit counters and forces the device into a low-power standby mode. Note that this pin will *not* enable/disable the device in the Two-Wire Serial Programming mode ( $\overline{\text{SER EN}}$  Low).

### 4.8 GND

Ground pin. A 0.2  $\mu F$  decoupling capacitor between  $V_{CC}$  and GND is recommended.

### 4.9 CEO

8

Chip Enable Output (active Low). This output goes Low when the address counter has reached its maximum value. In a daisy chain of AT17LV series devices, the  $\overline{\text{CEO}}$  pin of one device must be connected to the  $\overline{\text{CE}}$  input of the next device in the chain. It will stay Low as long as  $\overline{\text{CE}}$  is Low and OE is High. It will then follow CE until OE goes Low; thereafter,  $\overline{\text{CEO}}$  will stay High until the entire EEPROM is read again. This  $\overline{\text{CEO}}$  feature is not available on the AT17LV65 device.

# AT17LV65/128/256/512/010/002/040

### 4.10 A2

Device selection input, A2. This is used to enable (or select) the device during programming (i.e., when SER\_EN is Low). A2 has an internal pull-down resistor.

### **4.11 READY**

Open collector reset state indicator. Driven Low during power-up reset, released when power-up is complete. It is recommended to use a 4.7  $k\Omega$  pull-up resistor when this pin is used.

### 4.12 **SER EN**

Serial enable must be held High during FPGA loading operations. Bringing  $\overline{SER}_{EN}$  Low enables the Two-Wire Serial Programming Mode. For non-ISP applications,  $\overline{SER}_{EN}$  should be tied to  $V_{CC}$ .

### 4.13 V<sub>CC</sub>

3.3V (±10%) and 5.0V (±5% Commercial, ±10% Industrial) power supply pin.

### 5. FPGA Master Serial Mode Summary

The I/O and logic functions of any SRAM-based FPGA are established by a configuration program. The program is loaded either automatically upon power-up, or on command, depending on the state of the FPGA mode pins. In Master mode, the FPGA automatically loads the configuration program from an external memory. The AT17LV Serial Configuration EEPROM has been designed for compatibility with the Master Serial mode.

This document discusses the Atmel AT40K, AT40KAL and AT94KAL applications as well as Xilinx applications.

# 6. Control of Configuration

Most connections between the FPGA device and the AT17LV Serial EEPROM are simple and self-explanatory.

- The DATA output of the AT17LV series configurator drives DIN of the FPGA devices.
- The master FPGA CCLK output drives the CLK input of the AT17LV series configurator.
- The  $\overline{\text{CEO}}$  output of any AT17LV series configurator drives the  $\overline{\text{CE}}$  input of the next configurator in a cascaded chain of EEPROMs.
- SER\_EN must be connected to V<sub>CC</sub> (except during ISP).
- The READY<sup>(1)</sup> pin is available as an open-collector indicator of the device's reset status; it is driven Low while the device is in its power-on reset cycle and released (tri-stated) when the cycle is complete.

Note: 1. This pin is not available for the AT17LV65/128/256 devices.





# 7. Cascading Serial Configuration EEPROMs

For multiple FPGAs configured as a daisy-chain, or for FPGAs requiring larger configuration memories, cascaded configurators provide additional memory.

After the last bit from the first configurator is read, the clock signal to the configurator asserts its  $\overline{\text{CEO}}$  output Low and disables its DATA line driver. The second configurator recognizes the Low level on its  $\overline{\text{CE}}$  input and enables its DATA output.

After configuration is complete, the address counters of all cascaded configurators are reset if the RESET/OE on each configurator is driven to its active (Low) level.

If the address counters are not to be reset upon completion, then the RESET/OE input can be tied to its inactive (High) level.

The AT17LV65 devices do not have the CEO feature to perform cascaded configurations.

### 8. AT17LV Series Reset Polarity

The AT17LV series configurator allows the user to program the reset polarity as either RESET/OE or RESET/OE. This feature is supported by industry-standard programmer algorithms.

### 9. Programming Mode

The programming mode is entered by bringing  $\overline{SER}$ \_EN Low. In this mode the chip can be programmed by the Two-Wire serial bus. The programming is done at  $V_{CC}$  supply only. Programming super voltages are generated inside the chip.

# 10. Standby Mode

The AT17LV series configurators enter a low-power standby mode whenever  $\overline{\text{CE}}$  is asserted High. In this mode, the AT17LV65/128/256 configurator consumes less than 50  $\mu\text{A}$  of current at 3.3V (100  $\mu\text{A}$  for the AT17LV512/010 and 200  $\mu\text{A}$  for the AT17LV002/040). The output remains in a high-impedance state regardless of the state of the  $\overline{\text{OE}}$  input.

# AT17LV65/128/256/512/010/002/040

# 11. Absolute Maximum Ratings\*

Operating Temperature40°C to +85°C
Storage Temperature65 °C to +150 °C
Voltage on Any Pin with Respect to Ground0.1V to $V_{\rm CC}$ +0.5V
Supply Voltage (V <sub>CC</sub> )0.5V to +7.0V
Maximum Soldering Temp. (10 sec. @ 1/16 in.)260°C
ESD (R <sub>ZAP</sub> = 1.5K, C <sub>ZAP</sub> = 100 pF)

\*NOTICE:

Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those listed under operating conditions is not implied. Exposure to Absolute Maximum Rating conditions for extended periods of time may affect device reliability.

# 12. Operating Conditions

			3	.3V	5		
Symbol	Description		Min	Max	Min	Max	Units
V	Commercial	Supply voltage relative to GND -0°C to +70°C	3.0	3.6	4.75	5.25	V
V <sub>cc</sub>	Industrial	Supply voltage relative to GND -40°C to +85°C	3.0	3.6	4.5	5.5	V





# 13. DC Characteristics

 $V_{CC} = 3.3V \pm 10\%$ 

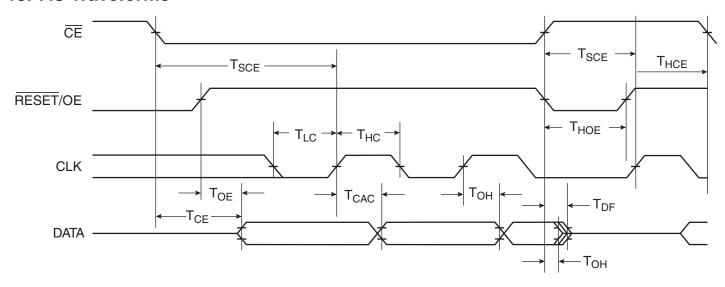
				AT17LV65/ AT17LV128/ AT17LV256		_V512/ LV010	AT17LV002/ AT17LV040		
Symbol	Description		Min	Max	Min	Max	Min	Max	Units
V <sub>IH</sub>	High-level Input Voltage		2.0	V <sub>CC</sub>	2.0	V <sub>CC</sub>	2.0	V <sub>CC</sub>	V
V <sub>IL</sub>	Low-level Input Voltage		0	0.8	0	0.8	0	0.8	V
V <sub>OH</sub>	High-level Output Voltage (I <sub>OH</sub> = -2.5 mA)	O a management at	2.4		2.4		2.4		V
V <sub>OL</sub>	Low-level Output Voltage (I <sub>OL</sub> = +3 mA)	Commercial		0.4		0.4		0.4	V
V <sub>OH</sub>	High-level Output Voltage (I <sub>OH</sub> = -2 mA)	Lorent and the Lorent	2.4		2.4		2.4		V
V <sub>OL</sub>	Low-level Output Voltage (I <sub>OL</sub> = +3 mA)	Industrial		0.4		0.4		0.4	V
I <sub>CCA</sub>	Supply Current, Active Mode			5		5		5	mA
IL	Input or Output Leakage Current ( $V_{IN} = V_{CC}$	or GND)	-10	10	-10	10	-10	10	μΑ
	Outside Outside Objective Made	Commercial		50		100		150	μΑ
I <sub>ccs</sub>	Supply Current, Standby Mode	Industrial		100		100		150	μΑ

# 14. DC Characteristics

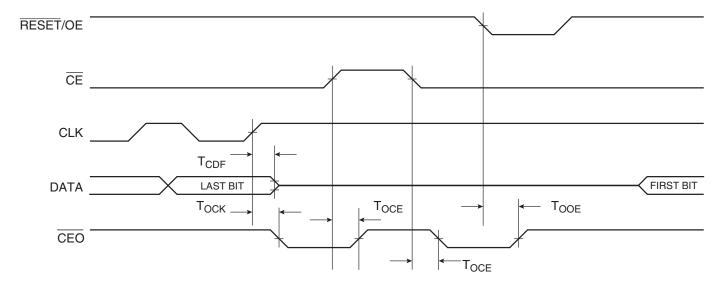
 $V_{CC}$  = 5V ± 5% Commercial;  $V_{CC}$  = 5V ± 10% Industrial

			AT17LV65/ AT17LV128/ AT17LV256		AT17LV512/ AT17LV010		AT17LV002/ AT17LV040		
Symbol	Description		Min	Max	Min	Max	Min	Max	Units
V <sub>IH</sub>	High-level Input Voltage		2.0	V <sub>CC</sub>	2.0	V <sub>CC</sub>	2.0	V <sub>CC</sub>	V
V <sub>IL</sub>	Low-level Input Voltage		0	0.8	0	0.8	0	0.8	V
V <sub>OH</sub>	High-level Output Voltage (I <sub>OH</sub> = -2.5 mA)	Common o maio l	3.7		3.86		3.86		V
V <sub>OL</sub>	Low-level Output Voltage (I <sub>OL</sub> = +3 mA)	Commercial		0.32		0.32		0.32	V
V <sub>OH</sub>	High-level Output Voltage (I <sub>OH</sub> = -2 mA)	landi satui al	3.6		3.76		3.76		V
V <sub>OL</sub>	Low-level Output Voltage (I <sub>OL</sub> = +3 mA)	Industrial		0.37		0.37		0.37	V
I <sub>CCA</sub>	Supply Current, Active Mode			10		10		10	mA
IL	Input or Output Leakage Current ( $V_{IN} = V_{CC}$	or GND)	-10	10	-10	10	-10	10	μA
	Cumply Current Standby Made	Commercial		75		200		350	μA
I <sub>ccs</sub>	Supply Current, Standby Mode	Industrial		150		200		350	μA

# 15. AC Waveforms



# 16. AC Waveforms when Cascading





### 17. AC Characteristics

 $V_{CC} = 3.3V \pm 10\%$ 

			AT17LV6	5/128/256	6	AT	17LV512	/010/002/	040	
		Commercial		Indu	strial	Commercial		Indu	strial	
Symbol	Description	Min	Max	Min	Max	Min	Max	Min	Max	Units
T <sub>OE</sub> <sup>(1)</sup>	OE to Data Delay		50		55		50		55	ns
T <sub>CE</sub> <sup>(1)</sup>	CE to Data Delay		60		60		55		60	ns
T <sub>CAC</sub> <sup>(1)</sup>	CLK to Data Delay		75		80		55		60	ns
T <sub>OH</sub>	Data Hold from $\overline{\text{CE}}$ , OE, or CLK	0		0		0		0		ns
T <sub>DF</sub> <sup>(2)</sup>	CE or OE to Data Float Delay		55		55		50		50	ns
T <sub>LC</sub>	CLK Low Time	25		25		25		25		ns
T <sub>HC</sub>	CLK High Time	25		25		25		25		ns
T <sub>SCE</sub>	CE Setup Time to CLK (to guarantee proper counting)	35		60		30		35		ns
T <sub>HCE</sub>	CE Hold Time from CLK (to guarantee proper counting)	0		0		0		0		ns
T <sub>HOE</sub>	OE High Time (guarantees counter is reset)	25		25		25		25		ns
F <sub>MAX</sub>	Maximum Clock Frequency		10		10		15		10	MHz

Notes: 1. AC test lead = 50 pF.

2. Float delays are measured with 5 pF AC loads. Transition is measured  $\pm$  200 mV from steady-state active levels.

# 18. AC Characteristics when Cascading

 $V_{CC} = 3.3V \pm 10\%$ 

			AT17LV65/128			AT	040			
		Comr	nercial	Industrial		Commercial		Industrial		
Symbol	Description	Min	Max	Min	Max	Min	Max	Min	Max	Units
T <sub>CDF</sub> <sup>(2)</sup>	CLK to Data Float Delay		60		60		50		50	ns
T <sub>OCK</sub> <sup>(1)</sup>	CLK to CEO Delay		55		60		50		55	ns
T <sub>OCE</sub> <sup>(1)</sup>	CE to CEO Delay		55		60		35		40	ns
T <sub>OOE</sub> <sup>(1)</sup>	RESET/OE to CEO Delay		40		45		35		35	ns
F <sub>MAX</sub>	Maximum Clock Frequency		8		8		12.5		10	MHz

Notes: 1. AC test lead = 50 pF.

2. Float delays are measured with 5 pF AC loads. Transition is measured ± 200 mV from steady-state active levels.

### 19. AC Characteristics

 $V_{CC}$  = 5V ± 5% Commercial;  $V_{CC}$  = 5V ± 10% Industrial

			AT17LV6	5/128/256	3	AT	17LV512/	010/002/	040	
		Comr	Commercial		Industrial		nercial	Industrial		
Symbol	Description	Min	Max	Min	Max	Min	Max	Min	Max	Units
T <sub>OE</sub> <sup>(1)</sup>	OE to Data Delay		30		35		30		35	ns
T <sub>CE</sub> <sup>(1)</sup>	CE to Data Delay		45		45		45		45	ns
T <sub>CAC</sub> <sup>(1)</sup>	CLK to Data Delay		50		55		50		50	ns
T <sub>OH</sub>	Data Hold from $\overline{\text{CE}}$ , OE, or CLK	0		0		0		0		ns
T <sub>DF</sub> <sup>(2)</sup>	CE or OE to Data Float Delay		50		50		50		50	ns
T <sub>LC</sub>	CLK Low Time	20		20		20		20		ns
T <sub>HC</sub>	CLK High Time	20		20		20		20		ns
T <sub>SCE</sub>	CE Setup Time to CLK (to guarantee proper counting)	35		40		20		25		ns
T <sub>HCE</sub>	CE Hold Time from CLK (to guarantee proper counting)	0		0		0		0		ns
T <sub>HOE</sub>	OE High Time (guarantees counter is reset)	20		20		20		20		ns
F <sub>MAX</sub>	Maximum Clock Frequency		12.5		12.5		15		15	MHz

Notes: 1. AC test lead = 50 pF.

2. Float delays are measured with 5 pF AC loads. Transition is measured ± 200 mV from steady-state active levels.

# 20. AC Characteristics when Cascading

 $V_{CC}$  = 5V ± 5% Commercial;  $V_{CC}$  = 5V ± 10% Industrial

			AT17LV6	5/128/256	6	AT				
		Comn	nercial	Industrial		Commercial		Industrial		
Symbol	Description	Min	Max	Min	Max	Min	Max	Min	Max	Units
T <sub>CDF</sub> <sup>(2)</sup>	CLK to Data Float Delay		50		50		50		50	ns
T <sub>OCK</sub> <sup>(1)</sup>	CLK to CEO Delay		35		40		35		40	ns
T <sub>OCE</sub> <sup>(1)</sup>	CE to CEO Delay		35		35		35		35	ns
T <sub>OOE</sub> <sup>(1)</sup>	RESET/OE to CEO Delay		30		35		30		30	ns
F <sub>MAX</sub>	Maximum Clock Frequency		10		10		12.5		12.5	MHz

Notes: 1. AC test lead = 50 pF.

2. Float delays are measured with 5 pF AC loads. Transition is measured ± 200 mV from steady-state active levels.





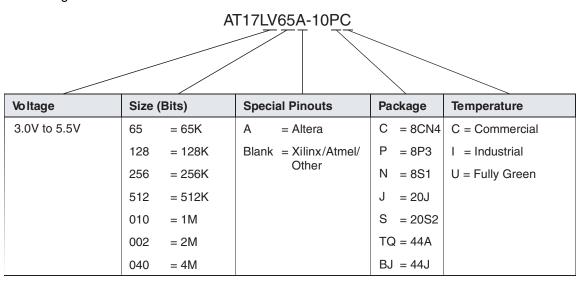
# 21. Thermal Resistance Coefficients<sup>(1)</sup>

Packag	је Туре		AT17LV65/ AT17LV128/ AT17LV256	AT17LV512/ AT17LV010	AT17LV002	AT17LV040
OCN		θ <sub>JC</sub> [°C/W]	45	45	45	-
8CN 4	Leadless Array Package (LAP)	θ <sub>JA</sub> [°C/W] <sup>(2)</sup>	115.71	135.71	159.60	-
	Diagtic Dual Inline Dealeage	θ <sub>JC</sub> [°C/W]	37	37	_	_
8P3	Plastic Dual Inline Package (PDIP)	θ <sub>JA</sub> [°C/W] <sup>(2)</sup>	107	107	_	-
	Diagtic Cull Wing Small Outline	θ <sub>JC</sub> [°C/W]	45	-	_	_
8S1	Plastic Gull Wing Small Outline (SOIC)	θ <sub>JA</sub> [°C/W] <sup>(2)</sup>	150	-	_	_
	Plantia London Chia Carrier	θ <sub>JC</sub> [°C/W]	35	35	35	_
20J	Plastic Leaded Chip Carrier (PLCC)	$\theta_{JA}$ [°C/W] <sup>(2)</sup>	90	90	90	-
	Diagtic Cull Wing Small Outline	θ <sub>JC</sub> [°C/W]				_
20\$2	Plastic Gull Wing Small Outline (SOIC)	θ <sub>JA</sub> [°C/W] <sup>(2)</sup>				-
	Thin Plastic Quad Flat	θ <sub>JC</sub> [°C/W]	_	-	17	17
44A	Package (TQFP)	θ <sub>JA</sub> [°C/W] <sup>(2)</sup>	_	-	62	62
	Plantia Loaded Chip Corrier	θ <sub>JC</sub> [°C/W]	_	ı	15	15
44J	Plastic Leaded Chip Carrier (PLCC)	θ <sub>JA</sub> [°C/W] <sup>(2)</sup>	_	_	50	50

Notes: 1. For more information refer to the "Thermal Characteristics of Atmel's Packages", available on the Atmel web site.

<sup>2.</sup> Airflow = 0 ft/min.

Figure 21-1. Ordering Code



	Package Type
8CN4	8-lead, 6 mm x 6 mm x 1 mm, Leadless Array Package (LAP) – Pin-compatible with 8-lead SOIC/VOID Packages
8P3	8-lead, 0.300" Wide, Plastic Dual Inline Package (PDIP)
8S1	8-lead, 0.150" Wide, Plastic Gull Wing Small Outline (JEDEC SOIC)
20J	20-lead, Plastic J-leaded Chip Carrier (PLCC)
20S2	20-lead, 0.300" Wide, Plastic Gull Wing Small Outline (JEDEC SOIC)
44A	44-lead, Thin (1.0 mm) Plastic Quad Flat Package Carrier (TQFP)
44J	44-lead, Plastic J-leaded Chip Carrier (PLCC)





# 22. Ordering Information

# 22.1 Standard Package Options

Memory Size	Ordering Code	Package	Operation Range
	AT17LV65-10CC	8CN4	
	AT17LV65-10PC	8P3	Communication
	AT17LV65-10NC	8S1	Commercial (0°C to 70°C)
	AT17LV65-10JC	20J	(0 0 10 10 0)
64-Kbit <sup>(1)</sup>	AT17LV65-10SC	20S2	
04-RDIL	AT17LV65-10CI	8CN4	
	AT17LV65-10PI	8P3	Industrial
	AT17LV65-10NI	8S1	(-40°C to 85°C)
	AT17LV65-10JI	20J	(-40 0 10 03 0)
	AT17LV65-10SI	20S2	
	AT17LV128-10CC	8CN4	
	AT17LV128-10PC	8P3	Commercial
	AT17LV128-10NC	8S1	(0°C to 70°C)
	AT17LV128-10JC	20J	(0 0 10 70 0)
128-Kbit <sup>(1)</sup>	AT17LV128-10SC	20S2	
120-KDIL**	AT17LV128-10Cl	8CN4	
	AT17LV128-10PI	8P3	Industrial
	AT17LV128-10NI	8S1	(-40°C to 85°C)
	AT17LV128-10JI	20J	( 40 0 10 00 0)
	AT17LV128-10SI	20\$2	
	AT17LV256-10CC	8CN4	
	AT17LV256-10PC	8P3	Commercial
	AT17LV256-10NC	8S1	(0°C to 70°C)
	AT17LV256-10JC	20J	(0 0 10 70 0)
256-Kbit <sup>(1)</sup>	AT17LV256-10SC	20\$2	
250-NDIL**	AT17LV256-10CI	8CN4	
	AT17LV256-10PI	8P3	Industrial
	AT17LV256-10NI	8S1	(-40°C to 85°C)
	AT17LV256-10JI	20J	( 10 0 10 00 0)
	AT17LV256-10SI	20S2	
	AT17LV512-10CC	8CN4	
	AT17LV512-10PC	8P3	Commercial
	AT17LV512-10JC	20J	(0°C to 70°C)
512-Kbit <sup>(1)</sup>	AT17LV512-10SC	20S2	
512-Kbit\''	AT17LV512-10Cl	8CN4	
	AT17LV512-10PI	8P3	Industrial
	AT17LV512-10JI	20J	(-40°C to 85°C)
	AT17LV512-10SI	20S2	

# AT17LV65/128/256/512/010/002/040

# 22.1 Standard Package Options (Continued)

Memory Size	Ordering Code	Package	Operation Range
	AT17LV010-10CC	8CN4	
	AT17LV010-10PC	8P3	Commercial
	AT17LV010-10JC	20J	(0°C to 70°C)
1-Mbit <sup>(1)</sup>	AT17LV010-10SC	20\$2	
I-WDIL'	AT17LV010-10CI	8CN4	
	AT17LV010-10PI	8P3	Industrial
	AT17LV010-10JI	20J	(-40°C to 85°C)
	AT17LV010-10SI	20\$2	
	AT17LV002-10CC	8CN4	
	AT17LV002-10JC	20J	
	AT17LV002-10SC	20\$2	Commercial (0°C to 70°C)
	AT17LV002-10TQC	44A	(0 0 10 70 0)
2-Mbit <sup>(1)</sup>	AT17LV002-10BJC	44J	
Z-IVIDILY/	AT17LV002-10Cl	8CN4	
	AT17LV002-10JI	20J	
	AT17LV002-10SI	20\$2	Industrial (-40°C to 85°C)
	AT17LV002-10TQI	44A	(-40 C to 85 C)
	AT17LV002-10BJI	44J	
	AT17LV040-10TQC	44A	Commercial
4-Mbit <sup>(1)</sup>	AT17LV040-10BJC	44J	(0°C to 70°C)
4-MINIT	AT17LV040-10TQI	44A	Industrial
	AT17LV040-10BJI	44J	(-40°C to 85°C)

Notes: 1. For operating 5V operating voltage, please refer to the corresponding AC and DC Characteristics.

<sup>2.</sup> The last-time buy is April 11, 2006 for shaded parts.

<sup>3.</sup> For the -10CC and -10Cl packages, customers may migrate to AT17LVXXX-10CU.



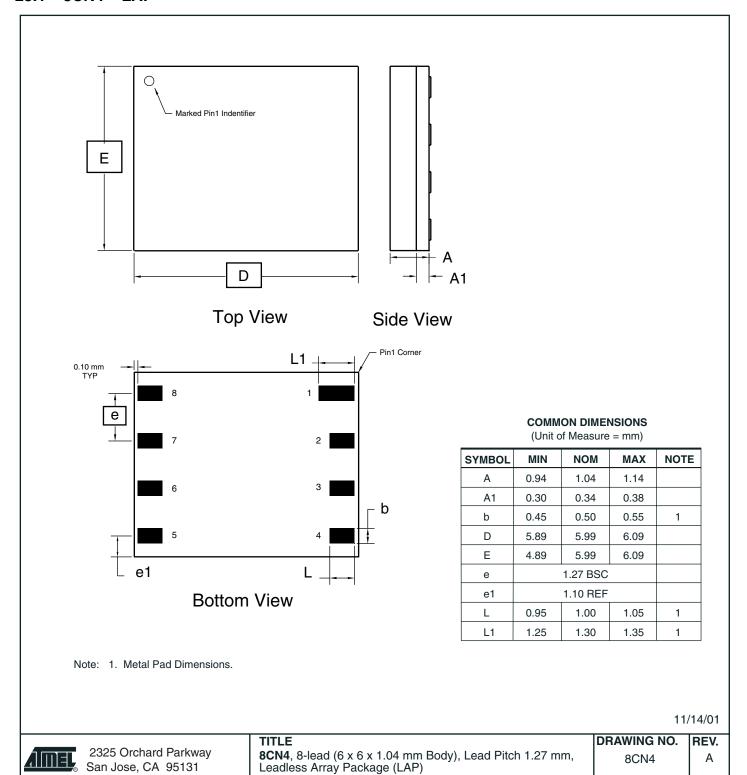
# 22.2 Green Package Options (Pb/Halide-free/RoHS Compliant)

Memory Size	Ordering Code	Package	Operation Range
	AT17LV256-10CU	8CN4	
	AT17LV256-10JU	20J	
256-Kbit <sup>(1)</sup>	AT17LV256-10NU	8S1	Industrial (-40°C to 85°C)
	AT17LV256-10PU	8P3	(-40 C to 65 C)
	AT17LV256-10SU	20S2	
512-Kbit <sup>(1)</sup>	AT17LV512-10CU	8CN4	Industrial
512-KUIL 7	AT17LV512-10JU	20J	(-40°C to 85°C)
	AT17LV010-10CU	8CN4	In direction
1-Mbit <sup>(1)</sup>	AT17LV010-10JU	20J	Industrial (-40°C to 85°C)
	AT17LV010-10PU	8P3	(-40 C to 85 C)
	AT17LV002-10CU	8CN4	
2-Mbit <sup>(1)</sup>	AT17LV002-10JU	20J	Industrial
Z-IVIDIL /	AT17LV002-10SU	20S2	(-40°C to 85°C)
	AT17LV002-10TQU	44A	
4-Mbit <sup>(1)</sup>	AT17LV040-10TQU	44A	Industrial (-40°C to 85°C)

Note: 1. For operating 5V operating voltage, please refer to the corresponding AC and DC Characteristics.

# 23. Packaging Information

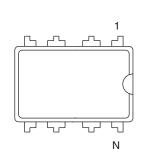
### 23.1 8CN4 - LAP



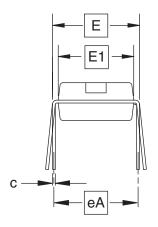




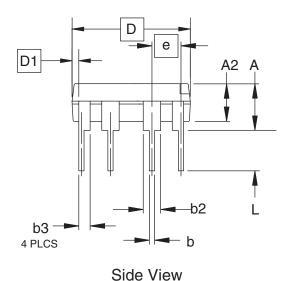
### 23.2 8P3 - PDIP



Top View



**End View** 



### **COMMON DIMENSIONS**

(Unit of Measure = inches)

SYMBOL	MIN	NOM	MAX	NOTE
Α			0.210	2
A2	0.115	0.130	0.195	
b	0.014	0.018	0.022	5
b2	0.045	0.060	0.070	6
b3	0.030	0.039	0.045	6
С	0.008	0.010	0.014	
D	0.355	0.365	0.400	3
D1	0.005			3
Е	0.300	0.310	0.325	4
E1	0.240	0.250	0.280	3
е	0.100 BSC			
eA	0.300 BSC		4	
L	0.115	0.130	0.150	2

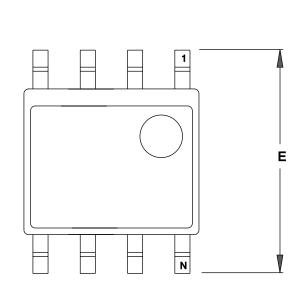
Notes

- 1. This drawing is for general information only; refer to JEDEC Drawing MS-001, Variation BA for additional information.
- 2. Dimensions A and L are measured with the package seated in JEDEC seating plane Gauge GS-3.
- 3. D, D1 and E1 dimensions do not include mold Flash or protrusions. Mold Flash or protrusions shall not exceed 0.010 inch.
- 4. E and eA measured with the leads constrained to be perpendicular to datum.
- 5. Pointed or rounded lead tips are preferred to ease insertion.
- 6. b2 and b3 maximum dimensions do not include Dambar protrusions. Dambar protrusions shall not exceed 0.010 (0.25 mm).

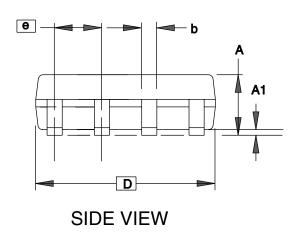
01/09/02

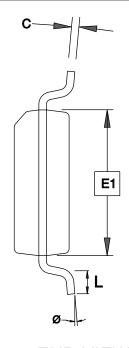
l		TITLE	DRAWING NO.	REV.
<u>Alm</u>	2325 Orchard Parkway San Jose, CA 95131	8P3, 8-lead, 0.300" Wide Body, Plastic Dual In-line Package (PDIP)	8P3	В

### 23.3 8S1 - SOIC



**TOP VIEW** 





**END VIEW** 

### COMMON DIMENSIONS

(Unit of Measure = mm)

SYMBOL	MIN	NOM	MAX	NOTE
Α	1.35	_	1.75	
A1	0.10	_	0.25	
b	0.31	_	0.51	
С	0.17	-	0.25	
D	4.80	-	5.05	
E1	3.81	-	3.99	
Е	5.79	_	6.20	
е		1.27 BSC		
L	0.40	_	1.27	
θ	0°	_	8°	

Note: These drawings are for general information only. Refer to JEDEC Drawing MS-012, Variation AA for proper dimensions, tolerances, datums, etc.

3/17/05

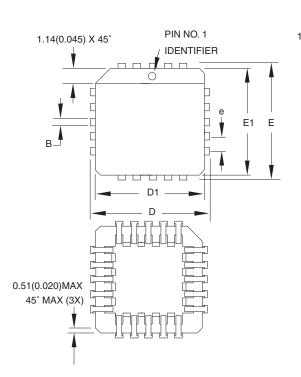
1150 E. Cheyenne Mtn. Blvd. Colorado Springs, CO 80906 **TITLE 8S1**, 8-lead (0.150" Wide Body), Plastic Gull Wing Small Outline (JEDEC SOIC)

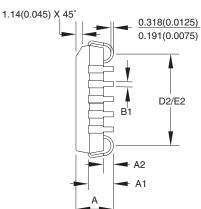
DRAWING NO. REV. 8S1 C





### 23.4 20J - PLCC





### **COMMON DIMENSIONS**

(Unit of Measure = mm)

SYMBOL	MIN	NOM	MAX	NOTE
Α	4.191	_	4.572	
A1	2.286	_	3.048	
A2	0.508	_	_	
D	9.779	_	10.033	
D1	8.890	_	9.042	Note 2
E	9.779	_	10.033	
E1	8.890	_	9.042	Note 2
D2/E2	7.366	_	8.382	
В	0.660	_	0.813	
B1	0.330	_	0.533	
е	1.270 TYP			

Notes:

- 1. This package conforms to JEDEC reference MS-018, Variation AA.
- 2. Dimensions D1 and E1 do not include mold protrusion. Allowable protrusion is .010"(0.254 mm) per side. Dimension D1 and E1 include mold mismatch and are measured at the extreme material condition at the upper or lower parting line.
- 3. Lead coplanarity is 0.004" (0.102 mm) maximum.

10/04/01

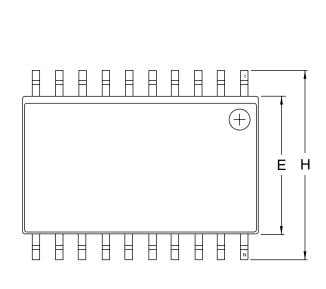
В

2325 Orchard Parkway San Jose, CA 95131

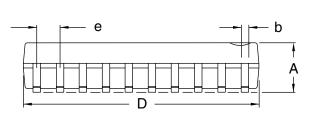
TITLE	
20J, 20-lead, Plastic J-leaded Chip Carrier (PLCC	2)

DRAWING NO. REV. 20J

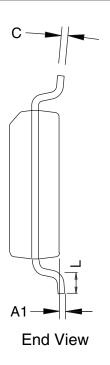
### 23.5 20S2 - SOIC



Top View



Side View



### **COMMON DIMENSIONS** (Unit of Measure = inches)

	•		· · ·	
SYMBOL	MIN	NOM	MAX	NOTE
Α	0.0926		0.1043	
A1	0.0040		0.0118	
b	0.0130		0.0200	4
С	0.0091		0.0125	
D	0.4961		0.5118	1
E	0.2914		0.2992	2
Н	0.3940		0.4190	
L	0.0160		0.050	3
е	0.	050 BSC		

Notes: 1. This drawing is for general information only; refer to JEDEC Drawing MS-013, Variation AC for additional information.

- 2. Dimension "D" does not include mold Flash, protrusions or gate burrs. Mold Flash, protrusions and gate burrs shall not exceed 0.15 mm (0.006") per side.
- 3. Dimension "E" does not include inter-lead Flash or protrusion. Inter-lead Flash and protrusions shall not exceed 0.25 mm (0.010") per side.
- "L" is the length of the terminal for soldering to a substrate.

  The lead width "b", as measured 0.36 mm (0.014") or greater above the seating plane, shall not exceed a maximum value of 0.61 mm 1/9/02 (0.024") per side.

2325 Orchard Parkway San Jose, CA 95131	TITLE 20S2, 20-lead, 0.300" Wide Body, Plastic Gull Wing Small Outline Package (SOIC)	DRAWING NO. 20S2	REV.
--	---	---------------------	------

